## 25Pt200B-H or 25Pt200A-H

The 25Pt200B-H is the high-spring constant RMN probe. It is typically used for non-contact and tapping mode AFM measurements. These probes are ideal for high Frequency applications.

- Tip shank length: 80 μm (± 25%)
- Cantilever length: 200 µm (± 15%)
- Cantilever width: 50 µm (± 15%)
- Spring constant: 250 N/m (± 40%)
- Frequency: 100 kHz (± 30%)
- Standard tip radii below 20 nm for \$90 each
- Tip radii below 10 nm on request for \$112 each 25Pt200B-H10
- Non standard probe tips and cantilevers upon request